

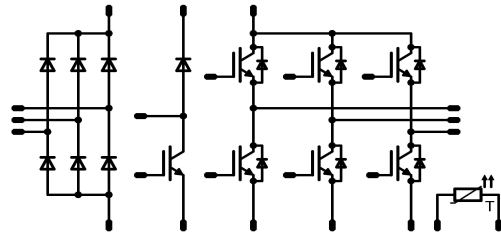
MiniSKiiP® 1 PIM
1200V / 8A
Features

- Solderless interconnection
- Trench Fieldstop IGBT3 technology

MiniSKiiP® 1 housing

Target Applications

- Industrial drives

Schematic

Types

- V23990-K209-A-PM

Maximum Ratings

 $T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
D8,D9,D10,D11,D12,D13				
Repetitive peak reverse voltage	V_{RRM}		1600	V
DC forward current	I_{FAV}	$T_j=T_{j,max}$ $T_h=80^{\circ}\text{C}$	29	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$ half sine wave $T_j=25^{\circ}\text{C}$	220	A
I^2t -value	I^2t		240	A^2s
Power dissipation	P_{tot}	$T_j=T_{j,max}$ $T_h=80^{\circ}\text{C}$	46	W
Maximum Junction Temperature	$T_{j,max}$		150	$^{\circ}\text{C}$

T1,T2,T3,T4,T5,T6,T7

Collector-emitter break down voltage	V_{CE}		1200	V
DC collector current	I_C	$T_j=T_{j,max}$ $T_h=80^{\circ}\text{C}$	18	A
Repetitive peak collector current	$I_{C,pulse}$	t_p limited by $T_{j,max}$	24	A
Power dissipation	P_{tot}	$T_j=T_{j,max}$ $T_h=80^{\circ}\text{C}$	62	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq 150^{\circ}\text{C}$ $V_{GE}=15\text{V}$	10 900	μs V
Maximum Junction Temperature	$T_{j,max}$		175	$^{\circ}\text{C}$

Maximum Ratings

 $T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
D1,D2,D3,D4,D5,D6,D7				
Repetitive peak reverse voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j=T_{jmax}$ $T_n=80^{\circ}\text{C}$	12	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	29	A
Power dissipation	P_{tot}	$T_j=T_{jmax}$ $T_n=80^{\circ}\text{C}$	28	W
Maximum Junction Temperature	T_{jmax}		150	$^{\circ}\text{C}$

Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	T_{op}		-40...+($T_{jmax} - 25$)	$^{\circ}\text{C}$

Insulation Properties

Insulation voltage	V_{is}	$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}[V]$ or $V_{GS}[V]$	$V_r[V]$ or $V_{CE}[V]$ or $V_{DS}[V]$	$I_c[A]$ or $I_F[A]$ or $I_b[A]$	T_j	Min	Typ	Max		
D8,D9,D10,D11,D12,D13										
Forward voltage	V_F				25	$T_j=25^\circ C$ $T_j=125^\circ C$		1,51 1,42		V
Threshold voltage (for power loss calc. only)	V_{th}				25	$T_j=25^\circ C$ $T_j=125^\circ C$		0,86 0,79		V
Slope resistance (for power loss calc. only)	r_t				25	$T_j=25^\circ C$ $T_j=125^\circ C$		0,03 0,03		Ω
Reverse current	I_r			1500		$T_j=25^\circ C$ $T_j=125^\circ C$			0,05	mA
Thermal resistance chip to heatsink	R_{thJH}	Thermal grease thickness \leq 50um $\lambda = 1$ W/mK						1,5		K/W

T1,T2,T3,T4,T5,T6,T7

Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,00015	$T_j=25^\circ C$ $T_j=150^\circ C$	5	5,8	5,6	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		8	$T_j=25^\circ C$ $T_j=150^\circ C$	1,1	1,75 1,85	1,9	V
Collector-emitter cut-off current incl. Diode	I_{CES}		0	1200		$T_j=25^\circ C$ $T_j=150^\circ C$			0,03	mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ C$ $T_j=150^\circ C$			300	nA
Integrated Gate resistor	R_{gint}							-		Ω
Turn-on delay time	$t_{d(on)}$	$R_{goff}=54 \Omega$ $R_{gon}=54 \Omega$	± 15	600	8	$T_j=25^\circ C$		46		ns
Rise time	t_r					$T_j=150^\circ C$		44		
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ C$		21		
Fall time	t_f					$T_j=150^\circ C$		27		
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ C$		317		
Turn-off energy loss per pulse	E_{off}	$T_j=150^\circ C$		385				0,65 0,82		mWs
Input capacitance	C_{ies}	$f=1$ MHz	0	25		$T_j=25^\circ C$		551		pF
Output capacitance	C_{oss}							40		
Reverse transfer capacitance	C_{rss}							17		
Gate charge	Q_{Gate}		± 15			$T_j=25^\circ C$		58		nC
Thermal resistance chip to heatsink	R_{thJH}	Thermal grease thickness \leq 50um $\lambda = 1$ W/mK						1,5		K/W

D1,D2,D3,D4,D5,D6,D7

Diode forward voltage	V_F				5	$T_j=25^\circ C$ $T_j=125^\circ C$		1,55 1,57	1,77	V
Peak reverse recovery current	I_{RRM}	$di(rec)/dt=$ tbD A/us	0	600	8	$T_j=25^\circ C$		7,8		A
Reverse recovery time	t_{rr}					$T_j=125^\circ C$		8,8		
Reverse recovered charge	Q_{rr}					$T_j=25^\circ C$		434		
Peak rate of fall of recovery current	$di(rec)max/dt$					$T_j=125^\circ C$		610		
Reverse recovered energy	E_{rec}					$T_j=25^\circ C$		1,16		
		$T_j=125^\circ C$		1,77				75 38		μC
Reverse recovered energy	E_{rec}	$T_j=25^\circ C$				$T_j=25^\circ C$		0,48		mWs
		$T_j=125^\circ C$				$T_j=125^\circ C$		0,75		mWs
Thermal resistance chip to heatsink	R_{thJH}	Thermal grease thickness \leq 50um $\lambda = 1$ W/mK						2,5		K/W

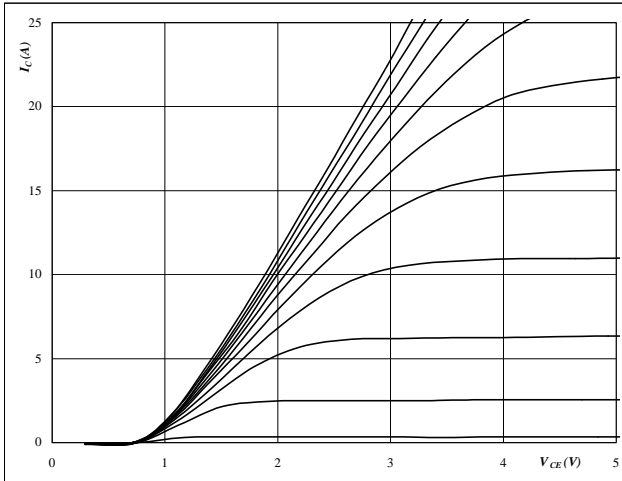
PTC

Rated resistance	R					$T=25^\circ C$		1000		Ω
Deviation of R100	$\Delta R/R$	$R_{100}=1670 \Omega$				$T=100^\circ C$	-3		3	%
R100	R					$T=100^\circ C$		1670,313		Ω
A-value	B(25/50)	Tol. %				$T=25^\circ C$		$7,635 \cdot 10^{-3}$		1/K
B-value	B(25/100)	Tol. %				$T=25^\circ C$		$1,731 \cdot 10^{-5}$		1/K ²
Vincotech NTC Reference									E	

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 1 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

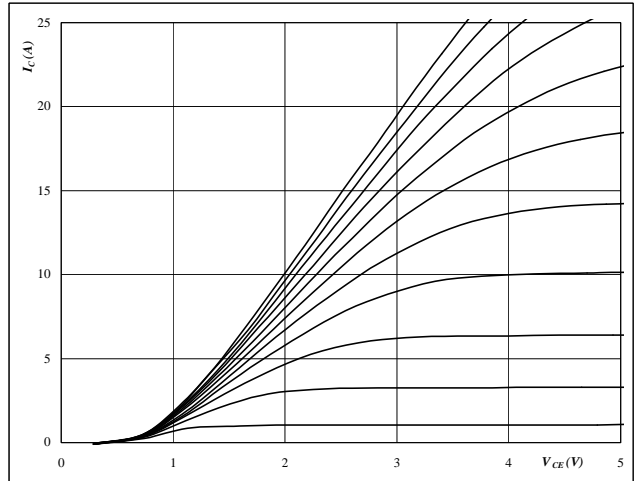


At
 $t_p = 250 \mu s$
 $T_j = 25 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

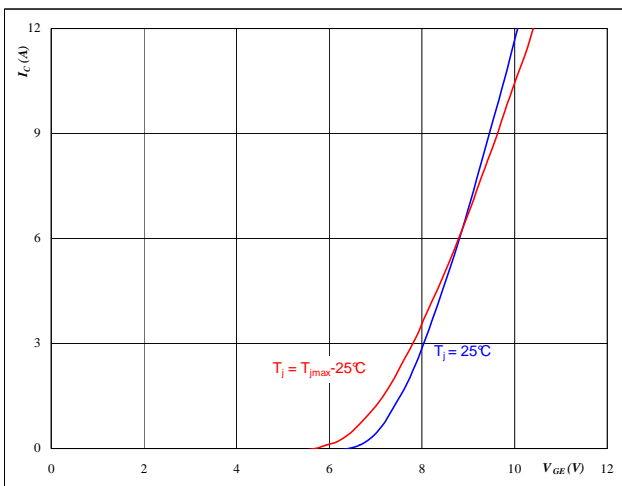


At
 $t_p = 250 \mu s$
 $T_j = 125 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

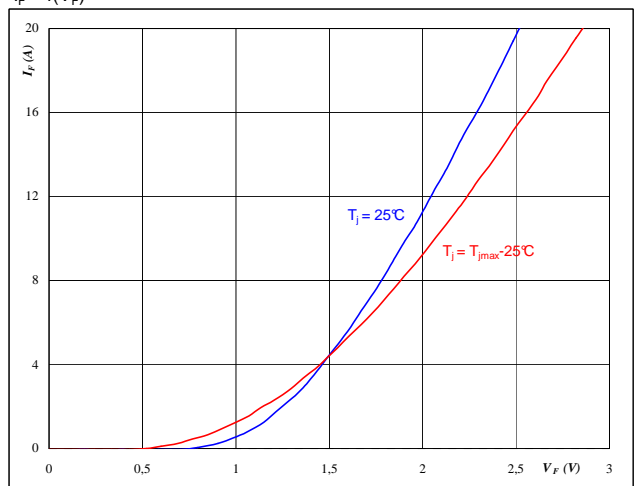


At
 $t_p = 250 \mu s$
 $V_{CE} = 10 \text{ V}$

Figure 4 FWD

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

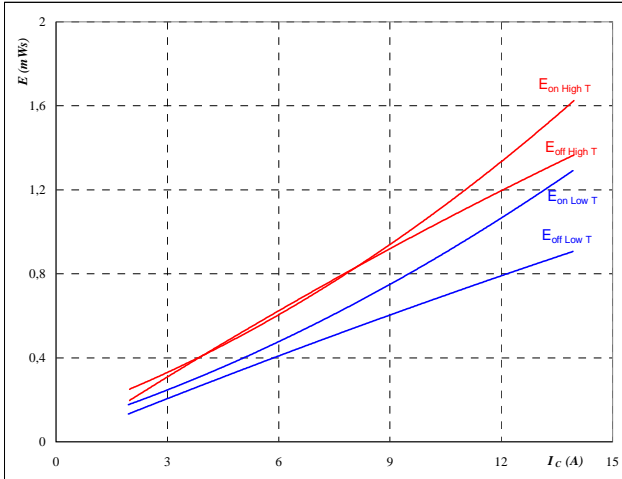


At
 $t_p = 250 \mu s$

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 5 IGBT

**Typical switching energy losses
as a function of collector current**

$$E = f(I_C)$$

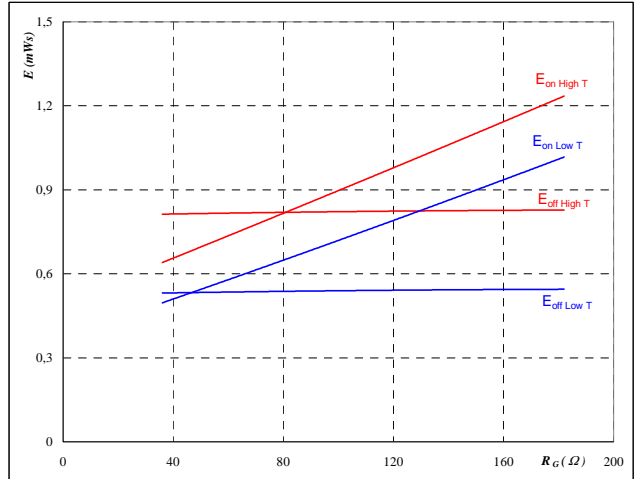


With an inductive load at

 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 81 \text{ } \Omega$
 $R_{goff} = 81 \text{ } \Omega$
Figure 6 IGBT

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$

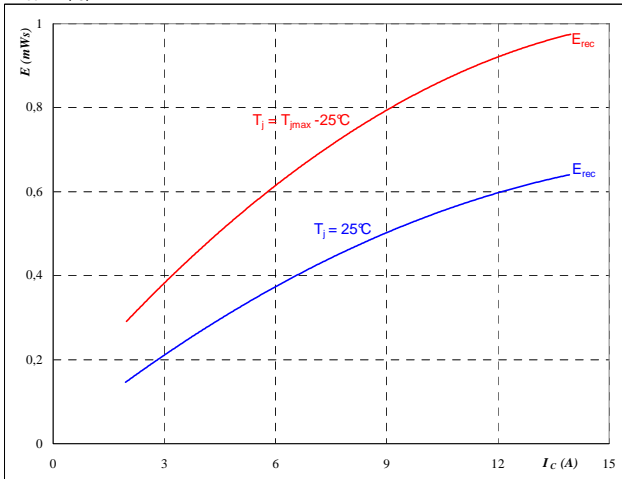


With an inductive load at

 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_C = 8 \text{ A}$
Figure 7 IGBT

**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_C)$$

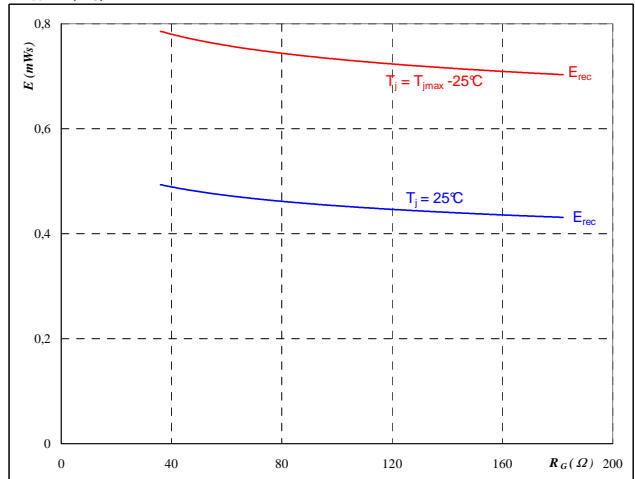


With an inductive load at

 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 81 \text{ } \Omega$
Figure 8 IGBT

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



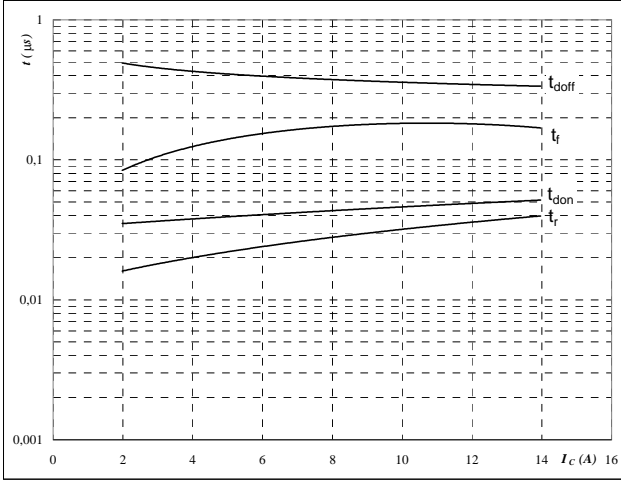
With an inductive load at

 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $I_C = 8 \text{ A}$

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 9 IGBT

Typical switching times as a function of collector current

$t = f(I_C)$



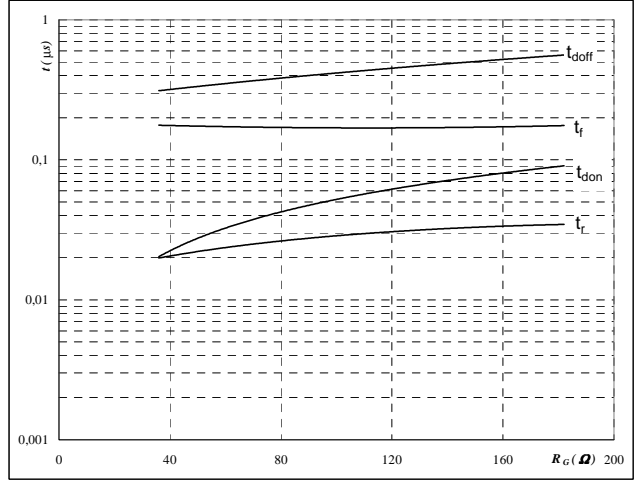
With an inductive load at

$T_J =$	125	°C
$V_{CE} =$	600	V
$V_{GE} =$	±15	V
$R_{gon} =$	81	Ω
$R_{goff} =$	81	Ω

Figure 10 IGBT

Typical switching times as a function of gate resistor

$t = f(R_G)$



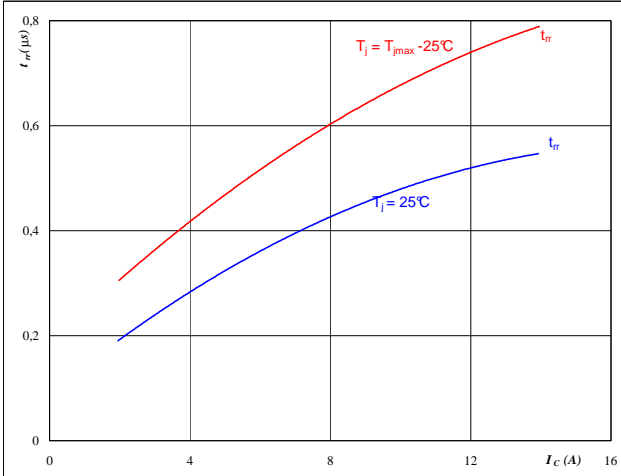
With an inductive load at

$T_J =$	125	°C
$V_{CE} =$	600	V
$V_{GE} =$	±15	V
$I_C =$	8	A

Figure 11 FWD

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$

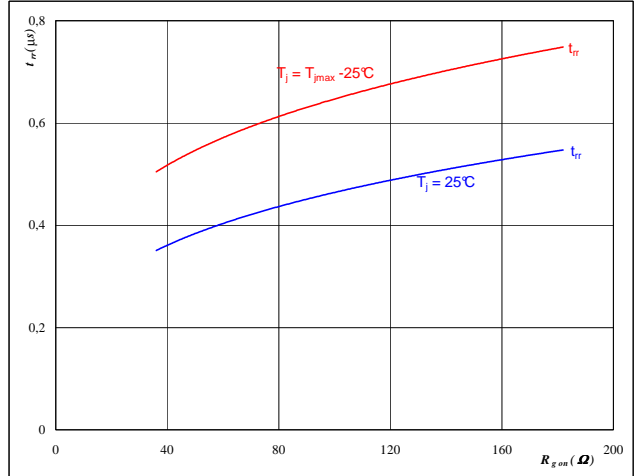

At

$T_J =$	25/125	°C
$V_{CE} =$	600	V
$V_{GE} =$	±15	V
$R_{gon} =$	81	Ω

Figure 12 FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$

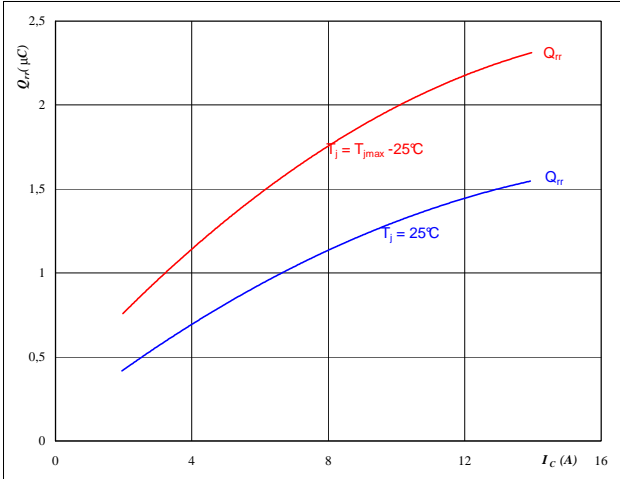

At

$T_J =$	25/125	°C
$V_R =$	600	V
$I_F =$	8	A
$V_{GE} =$	±15	V

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 13 FWD

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_C)$

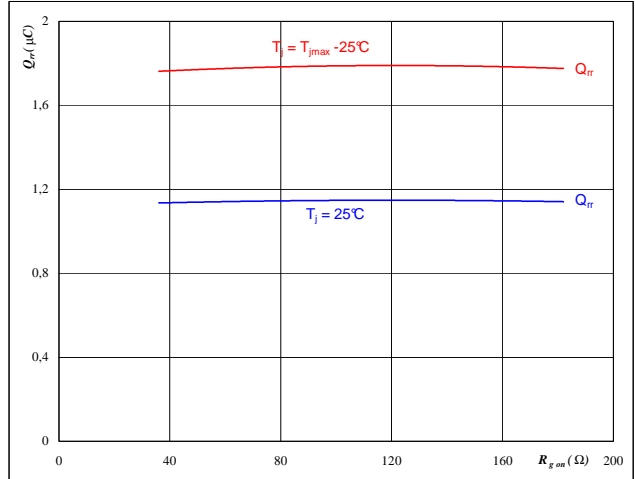


At
 $T_j = 25/125$ °C
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 81$ Ω

Figure 14 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$Q_{rr} = f(R_{gon})$

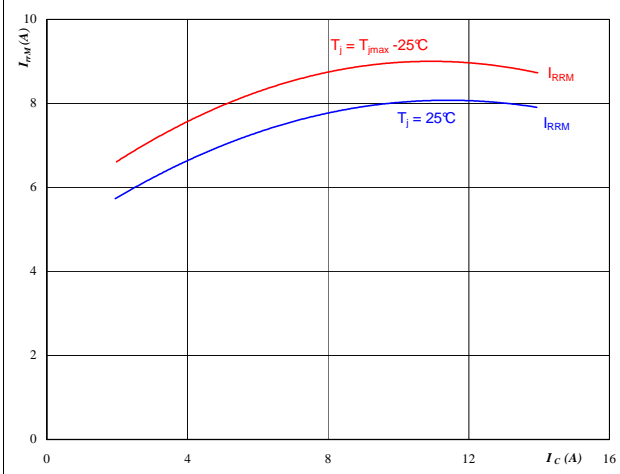


At
 $T_j = 25/125$ °C
 $V_R = 600$ V
 $I_F = 8$ A
 $V_{GE} = \pm 15$ V

Figure 15 FWD

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_C)$

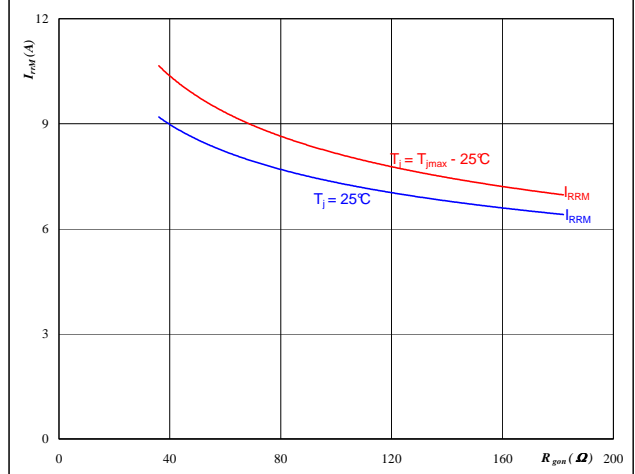


At
 $T_j = 25/125$ °C
 $V_{CE} = 600$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 81$ Ω

Figure 16 FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$I_{RRM} = f(R_{gon})$

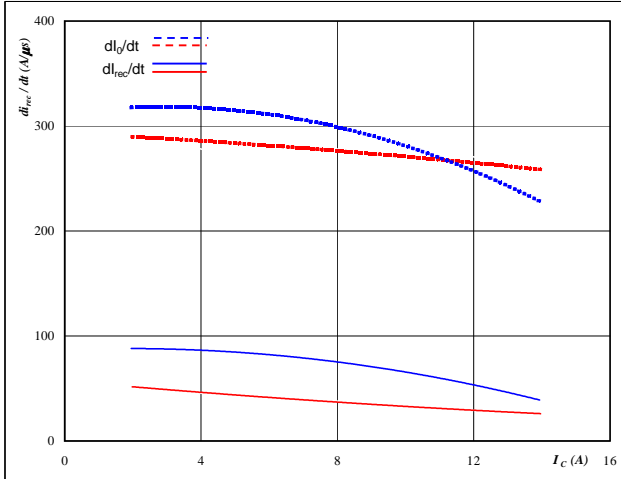


At
 $T_j = 25/125$ °C
 $V_R = 600$ V
 $I_F = 8$ A
 $V_{GE} = \pm 15$ V

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 17 FWD

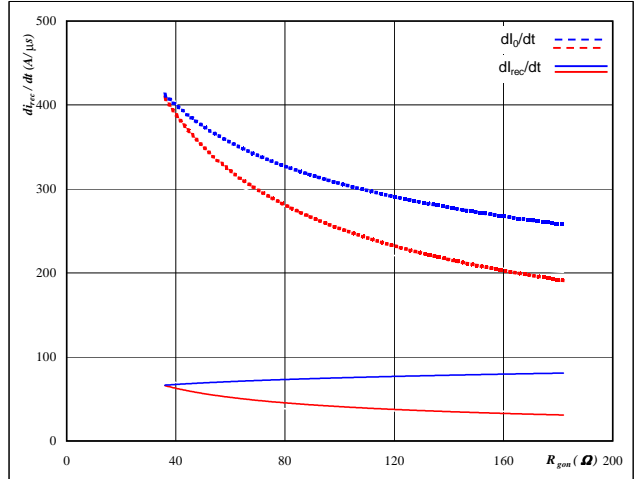
Typical rate of fall of forward and reverse recovery current as a function of collector current

$$di_f/dt, di_{rec}/dt = f(I_C)$$


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 600 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 81 \text{ } \Omega$
Figure 18 FWD

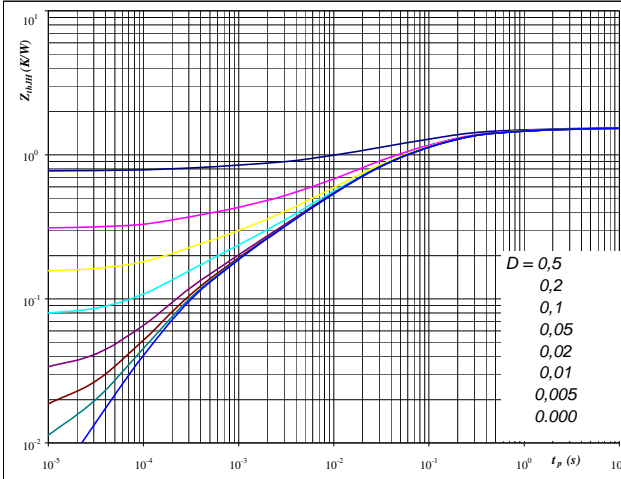
Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$di_f/dt, di_{rec}/dt = f(R_{gon})$$


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 600 \text{ V}$
 $I_F = 8 \text{ A}$
 $V_{GE} = \pm 15 \text{ V}$
Figure 19 IGBT

IGBT transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At
 $D = t_p / T$
 $R_{thJH} = 1,5 \text{ K/W}$

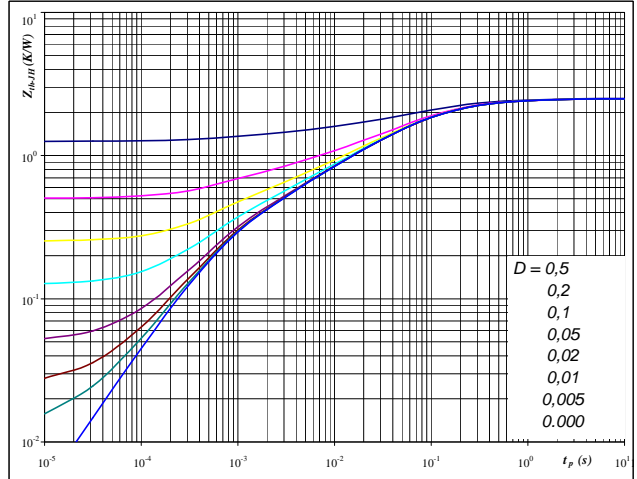
IGBT thermal model values

R (K/W)	Tau (s)
0,06	1,0E+01
0,18	5,8E-01
0,56	9,9E-02
0,46	1,8E-02
0,19	2,8E-03
0,10	2,9E-04

Figure 20 FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At
 $D = t_p / T$
 $R_{thJH} = 2,5 \text{ K/W}$

FWD thermal model values

R (K/W)	Tau (s)
0,05	9,0E+00
0,25	6,6E-01
0,88	1,2E-01
0,73	2,9E-02
0,33	4,8E-03
0,26	6,9E-04

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 21 IGBT

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

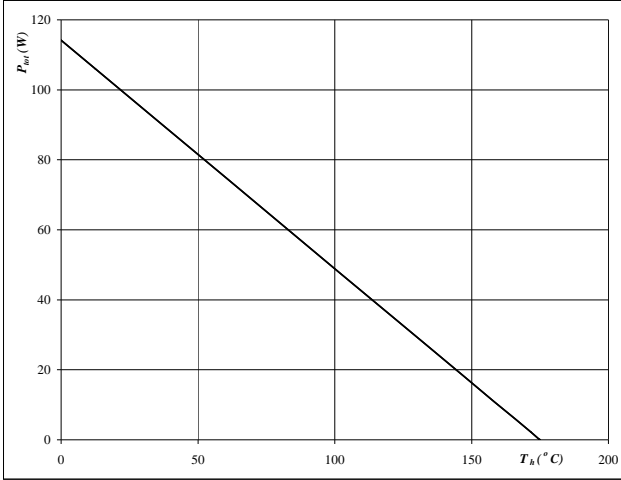

At
 $T_j = 175$ °C

Figure 22 IGBT

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$

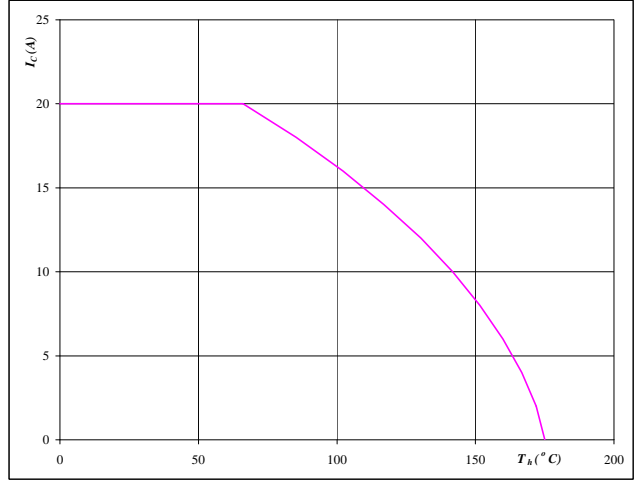

At
 $T_j = 175$ °C
 $V_{GE} = 15$ V

Figure 23 FWD

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

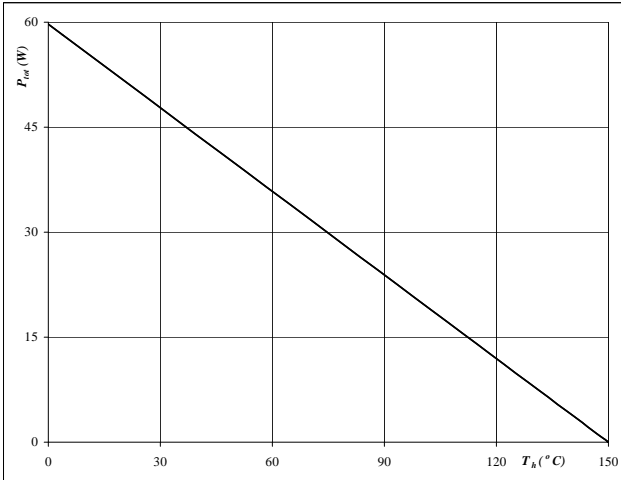
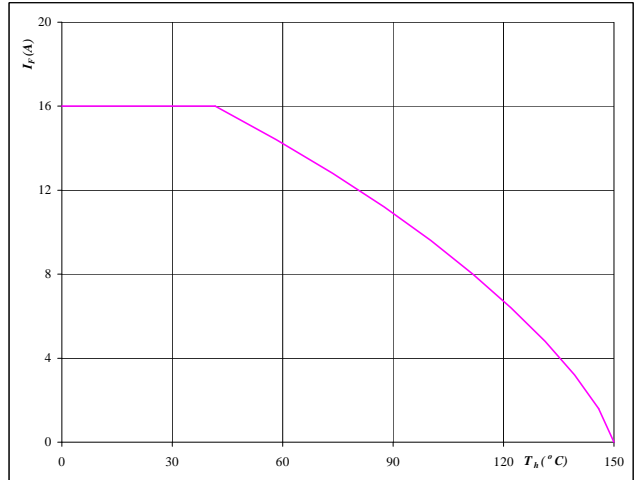

At
 $T_j = 150$ °C

Figure 24 FWD

Forward current as a function of heatsink temperature

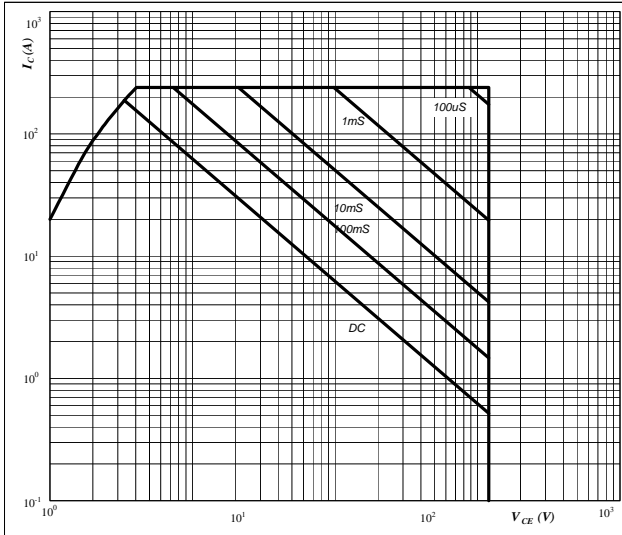
$$I_F = f(T_h)$$


At
 $T_j = 150$ °C

T1,T2,T3,T4,T5,T6,T7 / D1,D2,D3,D4,D5,D6,D7
Figure 25 IGBT

Safe operating area as a function of collector-emitter voltage

$$I_C = f(V_{CE})$$

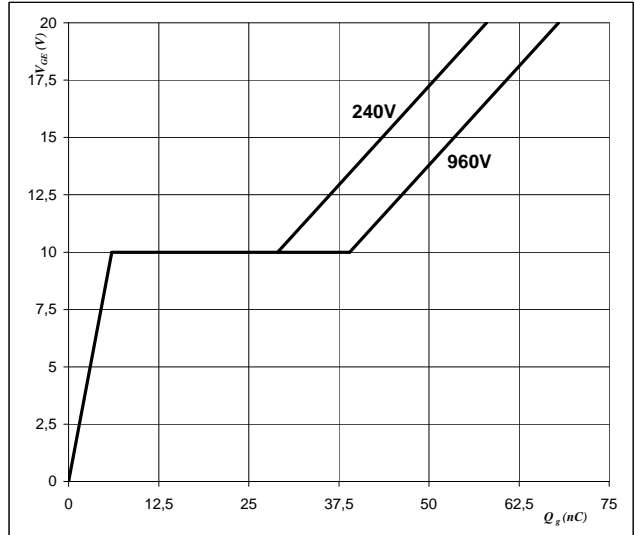


At
 D = single pulse
 $T_h = 80$ °C
 $V_{GE} = \pm 15$ V
 $T_j = T_{jmax}$ °C

Figure 26 IGBT

Gate voltage vs Gate charge

$$V_{GE} = f(Q_{GE})$$

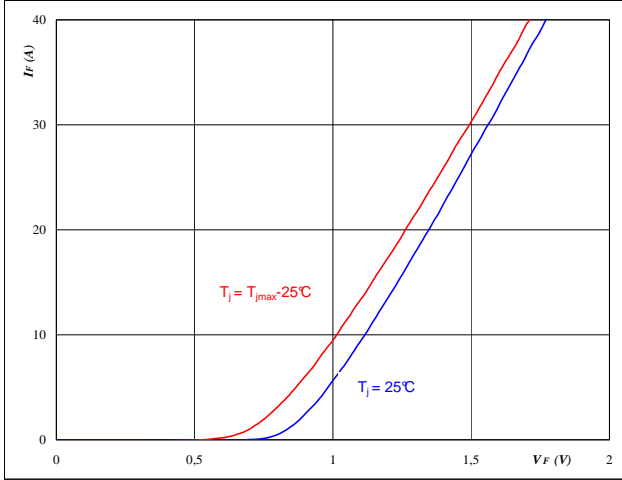


At
 $I_C = 8$ A

D8,D9,D10,D11,D12,D13
Figure 1 Diode

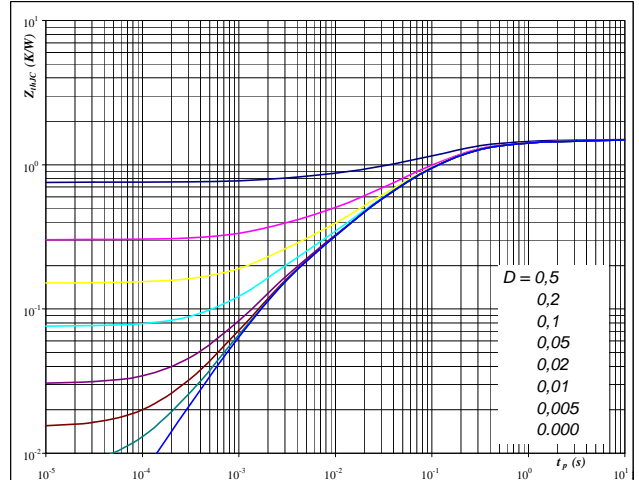
Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$


At
 $t_p = 250 \mu s$
Figure 2 Diode

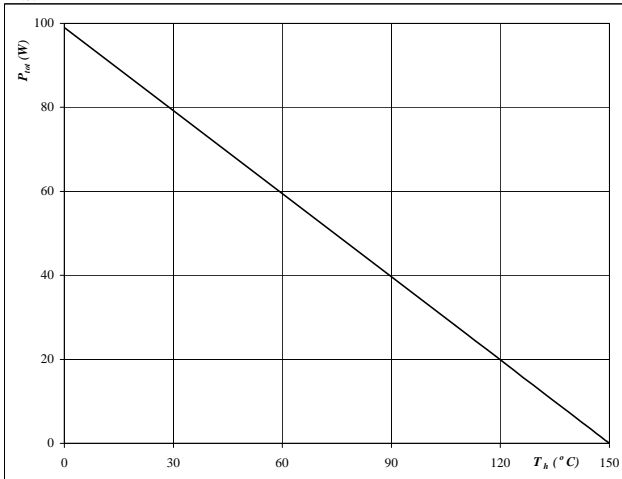
Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At
 $D = t_p / T$
 $R_{thJH} = 1,5 \text{ K/W}$
Figure 3 Diode

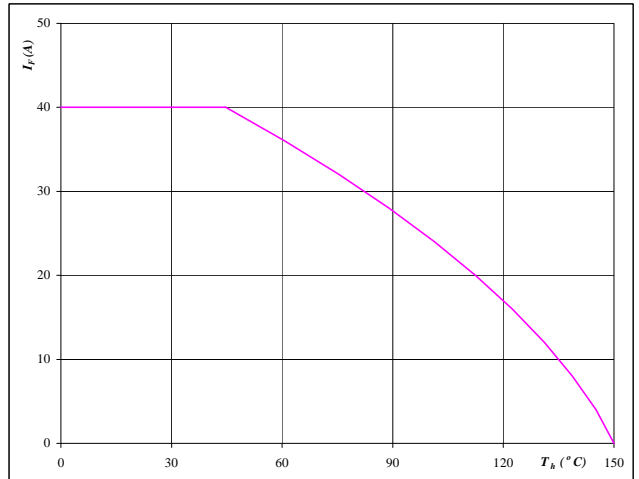
Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$


At
 $T_j = 150 \text{ °C}$
Figure 4 Diode

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

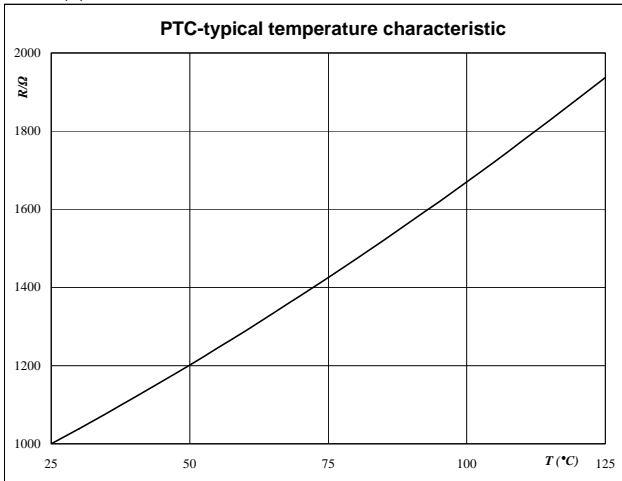

At
 $T_j = 150 \text{ °C}$

Thermistor

Figure 1 Thermistor

Typical PTC characteristic
as a function of temperature

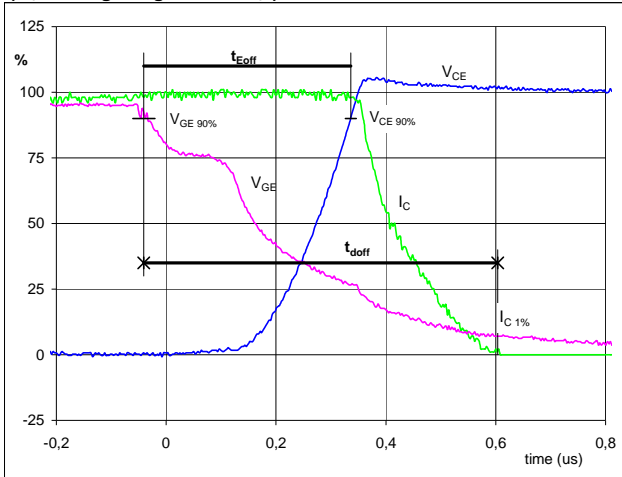
$$R_T = f(T)$$



Switching Definitions Output Inverter

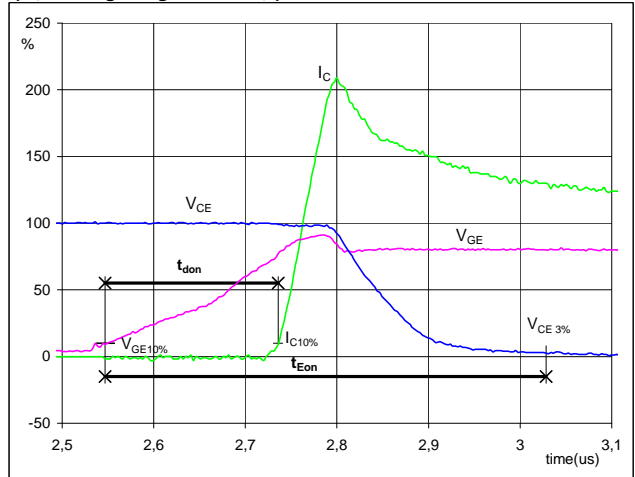
General conditions	
T_j	= 125 °C
R_{gon}	= 81 Ω
R_{goff}	= 81 Ω

Figure 1 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 (t_{Eoff} = integrating time for E_{off})


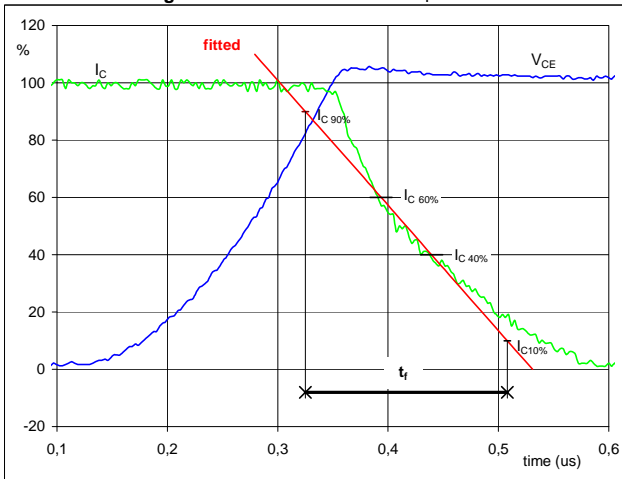
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	600	V
$I_C(100\%) =$	8	A
$t_{doff} =$	0,39	μ s
$t_{Eoff} =$	0,64	μ s

Figure 2 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 (t_{Eon} = integrating time for E_{on})


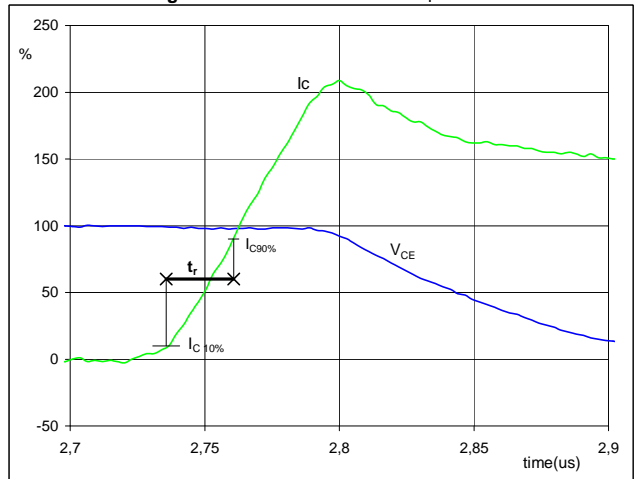
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	600	V
$I_C(100\%) =$	8	A
$t_{don} =$	0,04	μ s
$t_{Eon} =$	0,48	μ s

Figure 3 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_f


$V_C(100\%) =$	600	V
$I_C(100\%) =$	8	A
$t_f =$	0,17	μ s

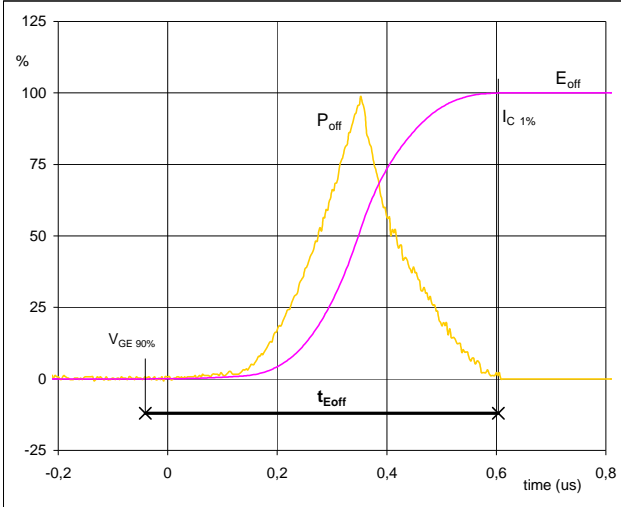
Figure 4 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_r


$V_C(100\%) =$	600	V
$I_C(100\%) =$	8	A
$t_r =$	0,03	μ s

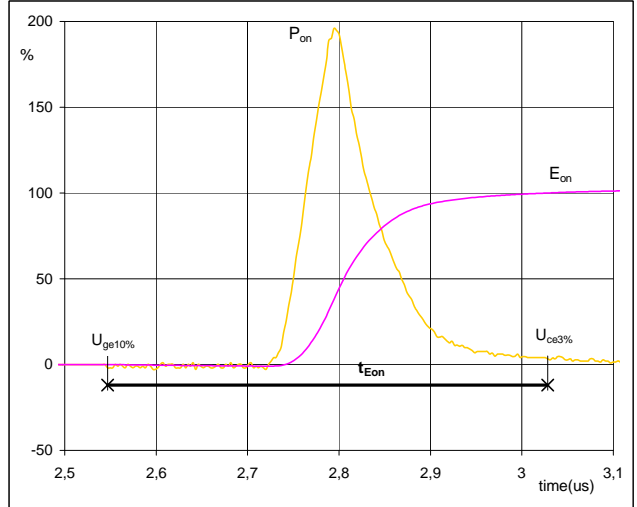
Switching Definitions Output Inverter

Figure 5 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{Eoff}


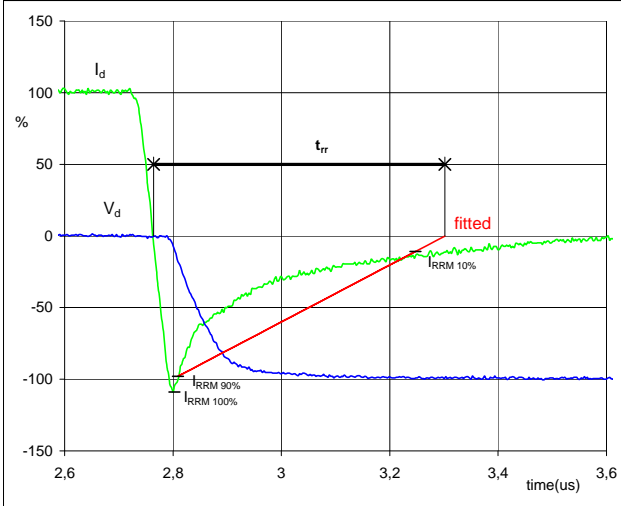
$P_{off} (100\%) = 4,79 \text{ kW}$
 $E_{off} (100\%) = 0,82 \text{ mJ}$
 $t_{Eoff} = 0,64 \text{ } \mu\text{s}$

Figure 6 Output inverter IGBT

Turn-on Switching Waveforms & definition of t_{Eon}


$P_{on} (100\%) = 4,79 \text{ kW}$
 $E_{on} (100\%) = 0,82 \text{ mJ}$
 $t_{Eon} = 0,48 \text{ } \mu\text{s}$

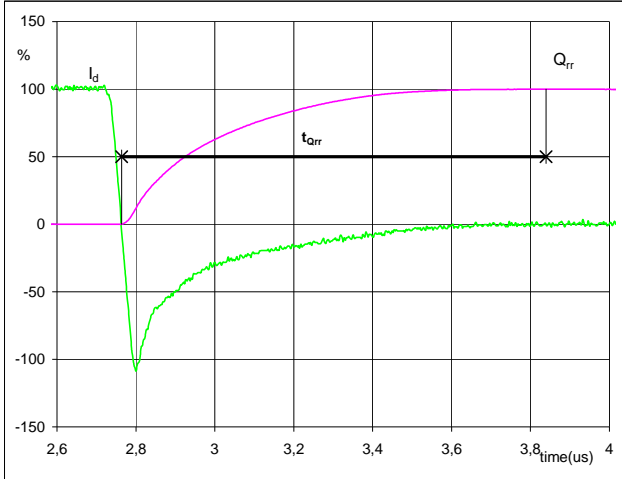
Figure 7 Output inverter IGBT

Turn-off Switching Waveforms & definition of t_{rr}


$V_d (100\%) = 600 \text{ V}$
 $I_d (100\%) = 8 \text{ A}$
 $I_{RRM} (100\%) = 9 \text{ A}$
 $t_{rr} = 0,61 \text{ } \mu\text{s}$

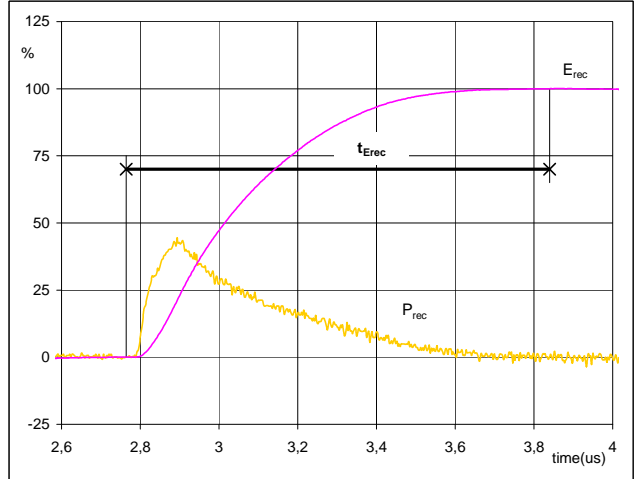
Switching Definitions Output Inverter

Figure 8 Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Qrr}
 (t_{Qrr} = integrating time for Q_{rr})


I_d (100%) =	8	A
Q_{rr} (100%) =	1,77	μC
t_{Qrr} =	1,08	μs

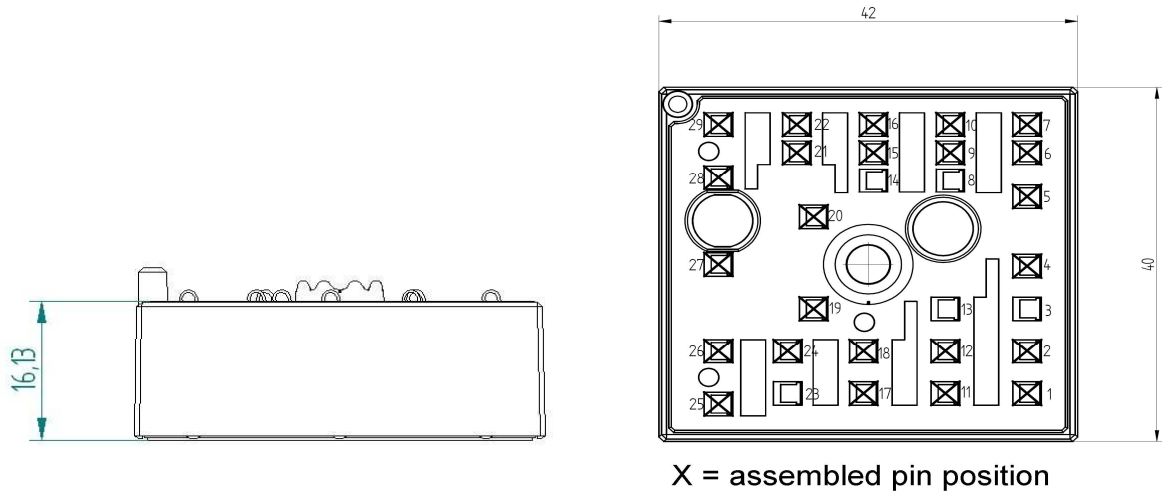
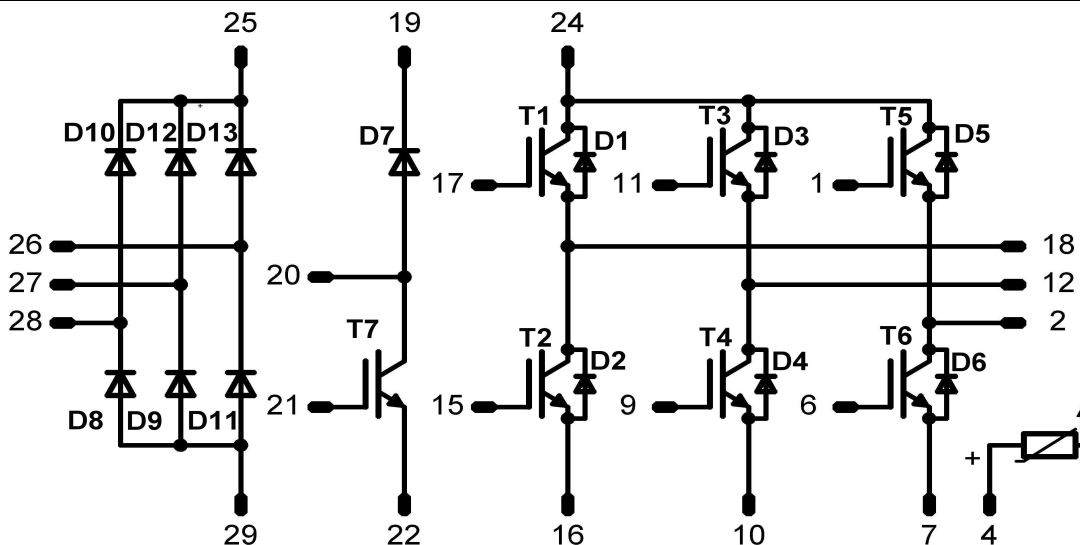
Figure 9 Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Erec}
 (t_{Erec} = integrating time for E_{rec})


P_{rec} (100%) =	4,79	kW
E_{rec} (100%) =	0,75	mJ
t_{Erec} =	1,08	μs

Ordering Code and Marking - Outline - Pinout
Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
with std lid (black V23990-K12-T-PM)	V23990-K209-A-/0A/-PM	K209A	K209A-/0A/
with std lid (black V23990-K12-T-PM) and P12	V23990-K209-A-/1A/-PM	K209A	K209A-/1A/
with thin lid (white V23990-K13-T-PM)	V23990-K209-A-/0B/-PM	K209A	K209A-/0B/
with thin lid (white V23990-K13-T-PM) and P12	V23990-K209-A-/1B/-PM	K209A	K209A-/1B/

Outline

Pinout


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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.